## Notice of References Cited Application/Control No. 10/577,426 Examiner Hai Vo Applicant(s)/Patent Under Reexamination MATSUMOTO ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0049715	03-2005	Ito et al.	623/023.5
*	В	US-2005/0031704	02-2005	Ahn, Edward S.	424/602
*	С	US-6,426,114	07-2002	Troczynski et al.	427/2.27
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	V						
	w						
	х						

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